MICROCHIP Semiconductor Device Type: JQC 064 LFBGA 9x9x1.72mm SAC305				Termination Base Alloy: Copper Alloy (Cu)			Package Homogeneous Materials: 8.1 Electronics (e.g. pc boards, displays)			
		"Contained In"	% Total			175.69	(mg) Total	Mold Compound	% ot Total Weight	56.04
Basic Substance	CAS Number 60676-86-0	Sub-Component	Weight 42.198	mg/part 132.291	ppm 421,981			-		
Silica(Amorphous) A Silica(Amorphous) B	7631-86-9	Mold Compound Mold Compound	5.626	17.639	56,264		Silica(Amorphous) A Silica(Amorphous) B	60676-86-0 7631-86-9	75.30 10.04	
Epoxy Resin	Trade Secret	Mold Compound	4.534	14.213	45,336		Epoxy Resin	Trade Secret	8.09	
Phenol Resin	9003-35-4	Mold Compound	1.687	5.288	16,868		Phenol Resin	9003-35-4	3.01	
Aluminium and its compounds	1332-58-7	Mold Compound	1.687	5.288	16,868	Alu	minium and its compounds	1332-58-7	3.01	
Carbon Black	1333-86-4	Mold Compound	0.308	0.966	3,082		Carbon Black	1333-86-4	0.55	
Copper	7440-50-8	Lead Frame	10.993	34.462	109,926		•	Total	100.00	
Glass fibers	65997-17-3	Lead Frame	6.553	20.543	65,527	95.99	(mg) Total	Lead Frame	% of Total Weight	30.62
Phenol, polymer	9003-36-5	Lead Frame	6.553	20.543	65,527		Copper	7440-50-8	35.90	
Silica, chemically prepared	7631-86-9	Lead Frame	2.450	7.679	24,496		Glass fibers	65997-17-3	21.40	
Nickel	7440-02-0	Lead Frame	1.194	3.744	11,942		Phenol, polymer	9003-36-5	21.40	
Barite	7727-43-7	Lead Frame	0.766	2.400	7,655	1	Silica, chemically prepared Nickel	7631-86-9	8.00	
Magnesium silicate Araldite GY 250	14807-96-6 25068-38-6	Lead Frame Lead Frame	0.612 0.612	1.920 1.920	6,124 6,124		Nickel Barite	7440-02-0 7727-43-7	3.90 2.50	
(2-Methoxymethylethoxy)propanol	34590-94-8	Lead Frame Lead Frame	0.612	0.768	2,450	1	Magnesium silicate	14807-96-6	2.50	
Bisphenol A	80-05-7	Lead Frame	0.459	1.440	4,593		Araldite GY 250	25068-38-6	2.00	
Aluminium-hydroxide-oxide	24623-77-6	Lead Frame	0.153	0.480	1,531	(2-Me	hoxymethylethoxy)propanol	34590-94-8	0.80	
Gold	7440-57-5	Lead Frame	0.031	0.096	306	(=	Bisphenol A	80-05-7	1.50	
Silicon	7440-21-3	Die Attach	0.525	1.646	5,250		Aluminium-hydroxide-oxide	24623-77-6	0.50	
Silver	7440-22-4	Die Attach	0.180	0.564	1,800		Gold	7440-57-5	0.10	
Epoxy Resin	Trade secret	Die Attach	0.045	0.141	450		<u>ll</u>	Total	100.00	
Silicon	7440-21-3	Chip (Die)	5.190	16.271	51,900	2.35	(mg) Total	Die Attach	% of Total Weight	0.75
Copper (Cu)	7440-50-8	Wire Bond	0.175	0.549	1,751		Silicon	7440-21-3	70.00	
Palladium	7440-05-3	Wire Bond				1				
			0.005	0.015	49		Silver	7440-22-4	24.00	
Tin	7440-31-5	Plating on external leads (pins)	0.005 6.967	0.015 21.842	49 69,673		Silver Epoxy Resin	7440-22-4 Trade secret	24.00 6.00	
Tin	7440-31-5	Plating on external leads (pins) Plating on external leads (pins) Plating on external leads (pins)	6.967 0.217 0.036	21.842 0.679 0.113	69,673 2,166 361	16.27		Trade secret	6.00	5.19
Tin Silver	7440-31-5 7440-22-4	Plating on external leads (pins) Plating on external leads (pins)	6.967 0.217 0.036	21.842 0.679	69,673 2,166	16.27	Epoxy Resin	Trade secret Total Chip (Die) 7440-21-3	6.00 100.00 % of Total Weight 100.00	5.19
Tin Silver	7440-31-5 7440-22-4 7440-50-8	Plating on external leads (pins) Plating on external leads (pins) Plating on external leads (pins)	6.967 0.217 0.036	21.842 0.679 0.113	69,673 2,166 361	16.27	Epoxy Resin (mg) Total	Trade secret Total Chip (Die)	6.00 100.00 % of Total Weight	5.19
Tin Silver Copper semiconductor device and its homogenous materials comply	7440-31-5 7440-22-4 7440-50-8 0.3135 y with EU Directives:	Plating on external leads (pins) Plating on external leads (pins) Plating on external leads (pins) TOTALS g Total Mass 2002/95/EC (27 January 2003) & Directive 2011/65/EU (0)	6.967 0.217 0.036 100.000	21.842 0.679 0.113 313.500	69,673 2,166 361 1,000,000		Epoxy Resin (mg) Total	Trade secret Total Chip (Die) 7440-21-3	6.00 100.00 % of Total Weight 100.00	5.19
Tin Silver Copper semiconductor device and its homogenous materials comply and 2000/53/EC and 2016/774/EU (End-of-Life Vehicles (ELV)	7440-31-5 7440-22-4 7440-50-8 0.3135 y with EU Directives:) without exemption (Plating on external leads (pins) Plating on external leads (pins) Plating on external leads (pins) TOTALS g Total Mass 2002/95/EC (27 January 2003) & Directive 2011/65/EU (0) (zero)	6.967 0.217 0.036 100.000	21.842 0.679 0.113 313.500	69,673 2,166 361 1,000,000		Epoxy Resin (mg) Total Doped Silicon (mg) Total	Trade secret Total Chip (Die) 7440-21-3 Total Wire Bond	6.00 100.00 % of Total Weight 100.00 100.00 % of Total Weight	
Tin Silver Copper semiconductor device and its homogenous materials comply and 2000/53/EC and 2016/774/EU (End-of-Life Vehicles (ELV pliance with the above EU Directives has been verified via intermical substance is absent from the list above, the chemical	7440-31-5 7440-22-4 7440-50-8 0.3135 y with EU Directives:) without exemption (ternal design controls at substance is NOT at	Plating on external leads (pins) Plating on external leads (pins) Plating on external leads (pins) TOTALS g Total Mass 2002/95/EC (27 January 2003) & Directive 2011/65/EU (0:/cero) s, supplier declarations, and /or analytical test data. an intentional ingredient in the semiconductor device and	6.967 0.217 0.036 100.000 B June 2011) a	21.842 0.679 0.113 313.500 and 2015/863/E	69,673 2,166 361 1,000,000 EU (31 March		Epoxy Resin (mg) Total Doped Silicon (mg) Total Copper (Cu)	Trade secret	6.00 100.00 % of Total Weight 100.00 100.00 % of Total Weight 97.30	
Tin Silver Copper semiconductor device and its homogenous materials comply	7440-31-5 7440-22-4 7440-50-8 0.3135 y with EU Directives:) without exemption (letnal design controls all substance is NOT a ent, there is no credib	Plating on external leads (pins) Plating on external leads (pins) Plating on external leads (pins) TOTALS g Total Mass 2002/95/EC (27 January 2003) & Directive 2011/65/EU (0: (zero) s, supplier declarations, and /or analytical test data. an intentional ingredient in the semiconductor device and ole reason to believe that the unavoidable impurity conce	6.967 0.217 0.036 100.000 B June 2011) a	21.842 0.679 0.113 313.500 and 2015/863/E	69,673 2,166 361 1,000,000 EU (31 March		Epoxy Resin (mg) Total Doped Silicon (mg) Total	Trade secret Total Total Chip (Die) 7440-21-3 Total Wire Bond 7440-50-8 7440-05-3	6.00 100.00 % of Total Weight 100.00 100.00 % of Total Weight 97.30 2.70	
Tin Silver Copper semiconductor device and its homogenous materials comply and 2000/53/EC and 2016/774/EU (End-of-Life Vehicles (ELV pliance with the above EU Directives has been verified via inthemical substance is absent from the list above, the chemica porated's knowledge and belief as of the date of this docume is not below the threshold of regulatory concern for any regu- ing compounds used by Microchip meet the UL94 V0 flamma	7440-31-5 7440-22-4 7440-50-8 0.3135 y with EU Directives:) without exemption (ternal design controls al substance is NOT a ent, there is no credit	Plating on external leads (pins) Plating on external leads (pins) Plating on external leads (pins) TOTALS g Total Mass 2002/95/EC (27 January 2003) & Directive 2011/65/EU (0/czero) s, supplier declarations, and /or analytical test data. an intentional ingredient in the semiconductor device and ole reason to believe that the unavoidable impurity conceivide.	6.967 0.217 0.036 100.000 B June 2011) a	21.842 0.679 0.113 313.500 and 2015/863/E	69,673 2,166 361 1,000,000 EU (31 March		Epoxy Resin (mg) Total Doped Silicon (mg) Total Copper (Cu)	Trade secret	6.00 100.00 % of Total Weight 100.00 100.00 % of Total Weight 97.30	
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Tin Silver Copper semiconductor device and its homogenous materials comply) and 2000/53/EC and 2016/774/EU (End-of-Life Vehicles (ELV) pliance with the above EU Directives has been verified via in hemical substance is absent from the list above, the chemica porated's knowledge and belief as of the date of this docume	7440-31-5 7440-22-4 7440-22-4 7440-50-8 0.3135 y with EU Directives:) without exemption (ternal design controls al substance is NOT a ant, there is no credit datory scheme world ability standard for place re made from polyvin is form concerning s is knowledge and bel en compiled based o d some information ind the average weigh	Plating on external leads (pins) TOTALS g Total Mass 2002/95/EC (27 January 2003) & Directive 2011/65/EU (0: (zero) s, supplier declarations, and /or analytical test data. an intentional ingredient in the semiconductor device and ple reason to believe that the unavoidable impurity concel-wide. astics. You can access the UL iQTM family of databases to access the date listed in this form. Microchip Technology In the ranges provided in Material Safety Data Sheets promay not have been provided by subcontract assemblers and of anticipated significant toxic metals components. The	6.967 0.217 0.036 100.000 B June 2011) a to the best o ontration of the oobtain a tes old the packin accorporated's yy Incorporate yided by raw rand raw mater	21.842 0.679 0.113 313.500 and 2015/863/E f Microchip Te chemical sub t report at g slip on the c semiconduct d cannot gual material suppliers.	69,673 2,166 361 1,000,000 iU (31 March echnology estance, if buter box and or devices in rantee the iers. Supplier information is	0.56	Epoxy Resin (mg) Total Doped Silicon (mg) Total Copper (Cu) Palladium	Trade secret	6.00 100.00 % of Total Weight 100.00 100.00 % of Total Weight 97.30 2.70	0.18
Tin Silver Copper Semiconductor device and its homogenous materials comply and 2000/53/EC and 2016/774/EU (End-of-Life Vehicles (ELV pliance with the above EU Directives has been verified via in the mical substance is absent from the list above, the chemical porated's knowledge and belief as of the date of this docume is not below the threshold of regulatory concern for any regular in compounds used by Microchip meet the UL94 V0 flamma //iq.ul.com/plastics/ protective "tubes" in which the specific product is shipped an in "reels" may be made from PVC plastic. Derip Technology Incorporated believes the information in the original packing materials is true and correct to the best of it pleteness and accuracy of data in this form because it has be mation is often protected from disclosure as trade secrets and ded only as estimates of the average weight of these parts a pants, metals, and non-metal materials contained within silicochip Technology Incorporated does not provide any warrant anties provided by Microchip Technology Incorporated and it attors, sales order acknowledgement, and invoices.	7440-31-5 7440-22-4 7440-22-4 7440-50-8 0.3135 y with EU Directives: y without exemption (ternal design controls al substance is NOT a ent, there is no credit latory scheme world ability standard for place re made from polyvin the form concerning s is knowledge and bel en compiled based o d some information i d the average weigh con devices (silicon to ty, express or implied is subsidiaries are co	Plating on external leads (pins) TOTALS g Total Mass 2002/95/EC (27 January 2003) & Directive 2011/65/EU (0: (zero) s, supplier declarations, and /or analytical test data. an intentional ingredient in the semiconductor device and ole reason to believe that the unavoidable impurity conceivide. astics. You can access the UL iQTM family of databases to the control of th	6.967 0.217 0.036 100.000 B June 2011) a to the best of obtain a test of the packin a test of the packin and raw mater asse estimates tion. The exclisale. These are	21.842 0.679 0.113 313.500 Ind 2015/863/E f Microchip Te ochemical subtreport at g slip on the company of the	69,673 2,166 361 1,000,000 U (31 March echnology estance, if outer box and or devices in rantee the iers. Supplier information is e trace levels product Microchip's	0.56	Epoxy Resin (mg) Total Doped Silicon (mg) Total Copper (Cu) Palladium (mg) Total	Trade secret	6.00 100.00 % of Total Weight 100.00 % of Total Weight 97.30 2.70 100.00 % of Total Weight	0.18
Tin Silver Copper semiconductor device and its homogenous materials comply and 2000/53/EC and 2016/774/EU (End-of-Life Vehicles (ELV bliance with the above EU Directives has been verified via intermical substance is absent from the list above, the chemical porated's knowledge and belief as of the date of this documes not below the threshold of regulatory concern for any regung compounds used by Microchip meet the UL94 V0 flamma (iq.ul.com/plastics/ rotective "tubes" in which the specific product is shipped at n "reels" may be made from PVC plastic. chip Technology Incorporated believes the information in thoriginal packing materials is true and correct to the best of it deleteness and accuracy of data in this form because it has be nation is often protected from disclosure as trade secrets and do only as estimates of the average weight of these parts a pants, metals, and non-metal materials contained within silic chip Technology Incorporated does not provide any warrant nities provided by Microchip Technology Incorporated and in	7440-31-5 7440-22-4 7440-50-8 0.3135 y with EU Directives:) without exemption (ternal design controls al substance is NOT a ent, there is no credib illatory scheme world ability standard for pl. ire made from polyvin is form concerning s is knowledge and bel en compiled based o id some information in the average weigh con devices (silicon li ty, express or implied is subsidiaries are co	Plating on external leads (pins) TOTALS g Total Mass 2002/95/EC (27 January 2003) & Directive 2011/65/EU (0: (zero) s, supplier declarations, and /or analytical test data. un intentional ingredient in the semiconductor device and ole reason to believe that the unavoidable impurity concelude. astics. You can access the UL iQTM family of databases the control of the co	6.967 0.217 0.036 100.000 B June 2011) a to the best of the best	21.842 0.679 0.113 313.500 and 2015/863/E f Microchip Te chemical subtreport at g slip on the companies of companies and supplicate suppliers. do not include usive, limited a provided in t, consequent	69,673 2,166 361 1,000,000 EU (31 March echnology estance, if outer box and or devices in rantee the leiers. Supplier Information is e trace levels product Microchip's ial or	0.56	Epoxy Resin (mg) Total Doped Silicon (mg) Total Copper (Cu) Palladium (mg) Total Tin	Trade secret Total Total Chip (Die) 7440-21-3 Total Wire Bond 7440-50-8 7440-05-3 Total Plating on external leads (pins)	6.00 100.00 % of Total Weight 100.00 % of Total Weight 97.30 2.70 100.00 % of Total Weight	0.18

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